

Notice of References Cited

Application/Control No.

10/561,528

Applicant(s)/Patent Under
Reexamination
TANIUCHI ET AL.

Examiner

HENOK LEGESSE

Art Unit

2861

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,059,407 A	05-2000	Komatsu et al.	347/103
*	B	US-2004/0182270 A1	09-2004	Wiedemer et al.	101/465
	C	US-			
	D	US-			
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	F	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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